Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10533690	CHOI ET AL.
Examiner	Art Unit

2617

SEARCHED						
Class	Subclass	Date	Examiner			
370	328, 336, 337, 347, 4522-356, 569, 401	2/19/2009	KA			
455	403, 422.1, 428, 445, 560-561	2/19/2009	KA			

KAMRAN AFSHAR

SEARCH NOTES		
Search Notes	Date	Examiner
East Search (US-PGPUB; USPAT; USOCR: FPRS: EPO; DERWENT; IBM TDB)	2/19/2009	KA
Dwayne Bost	2/19/2009	KA

INTERFERENCE SEARCH				
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